



Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10750082	VANDERVEEN ET AL.
	Examiner Washburn, Douglas N	Art Unit 2863

Notes	Date	Examiner
Inventor name search - see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
EAST keyword/keyphrase	06/15/2006	DNW
A61M031/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
A61M005/14 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G06F015/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G06F019/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
G011O013/00 see printout - (USPGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	06/15/2006	DNW
73/861 see printout - (USPGPUB; USPAT; USOCR)	06/15/2006	DNW
417/12, 18 see printout - (USPGPUB; USPAT; USOCR)	06/15/2006	DNW
604/65, 67, 81 see printout - (USPGPUB; USPAT; USOCR)	06/15/2006	DNW
702/98, 100, 127, 138, 140 see printout - (USPGPUB; USPAT; USOCR)	06/15/2006	DNW
Hoff, M AU 2857; 101 consult; suggested 101 rejection not applicable	06/19/2006	DNW
U.S. Patent and Trademark Office		Part of Paper No.: 20060615

<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10750082</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>VANDERVEEN ET AL.</p>
	<p>Examiner</p> <p>Washburn, Douglas N</p>	<p>Art Unit</p> <p>2863</p>

Class	SubClass	Date	Examiner
604	81	06/15/2006	DNW
702	98	06/15/2006	DNW
702	100	06/15/2006	DNW
U.S. Patent and Trademark Office		Part of Paper No.:	20060615